Notice of References Cited Application/Control No. 10/552,396 Examiner BRITT HANLEY Applicant(s)/Patent Under Reexamination AKIYAMA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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	Η	US-			
	I	US-			
	J	US-			
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	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP11-231891	08-1999	JP	Shinji et al.	
	0	3-75596	07-1991	JP	Oono	
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NON-PATENT DOCUMENTS

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